



In-focus performance from intra-focal measurements for large X-ray mirrors

Giuseppe Vacanti (cosine Science & Computing)

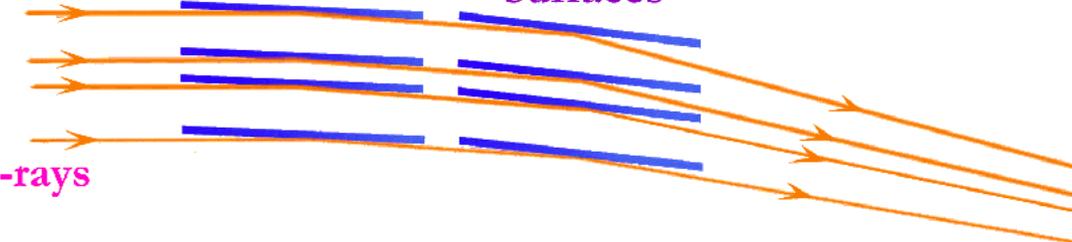
MEADOW 2013, Trieste, 28-30 October, 2013

Wolter I optics

Paraboloid
Surfaces

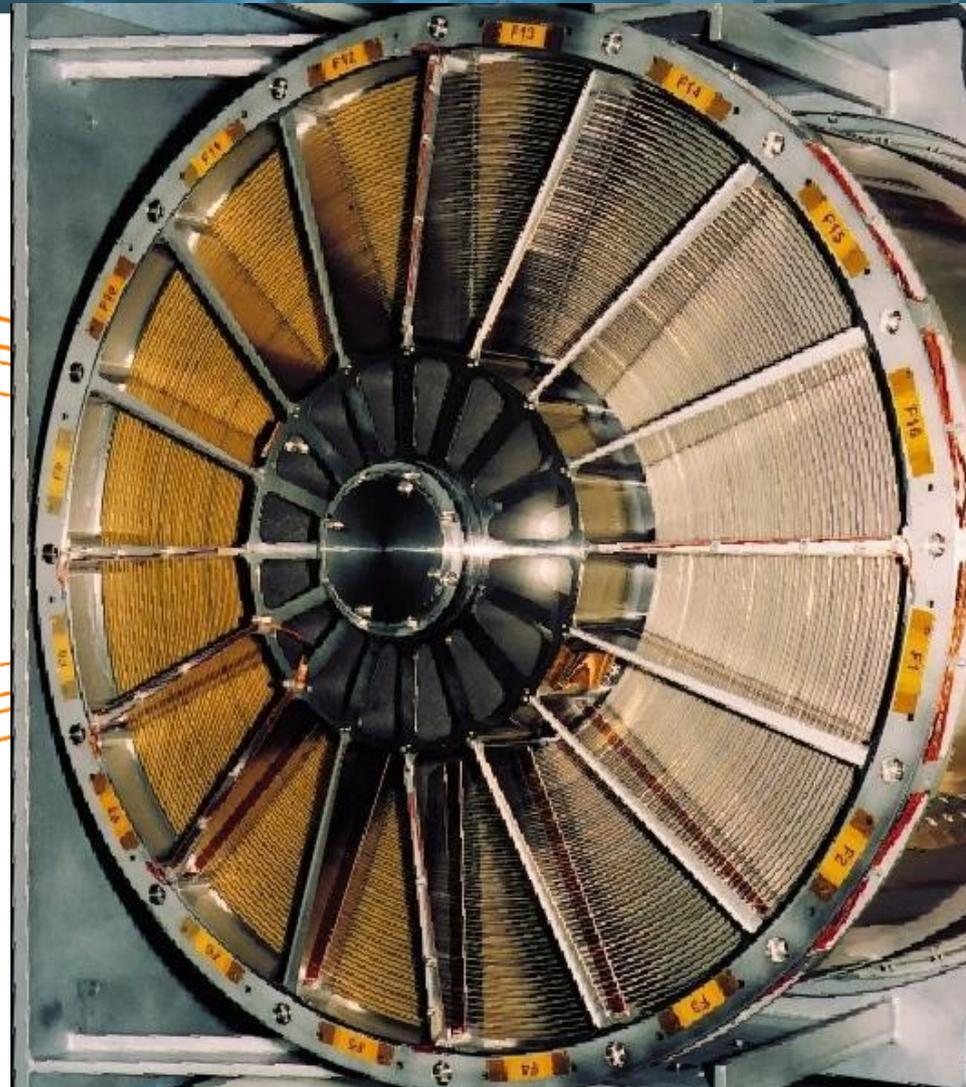
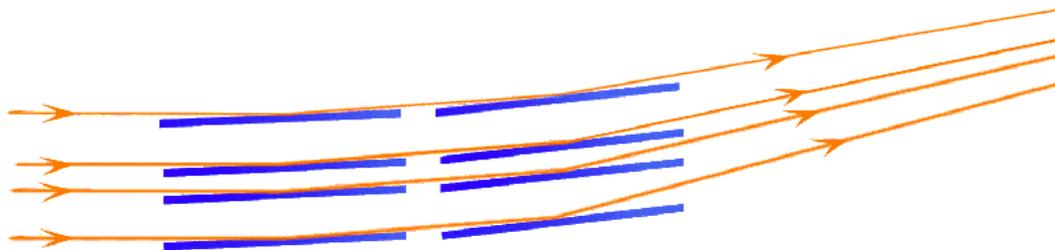
Hyperboloid
Surfaces

X-rays



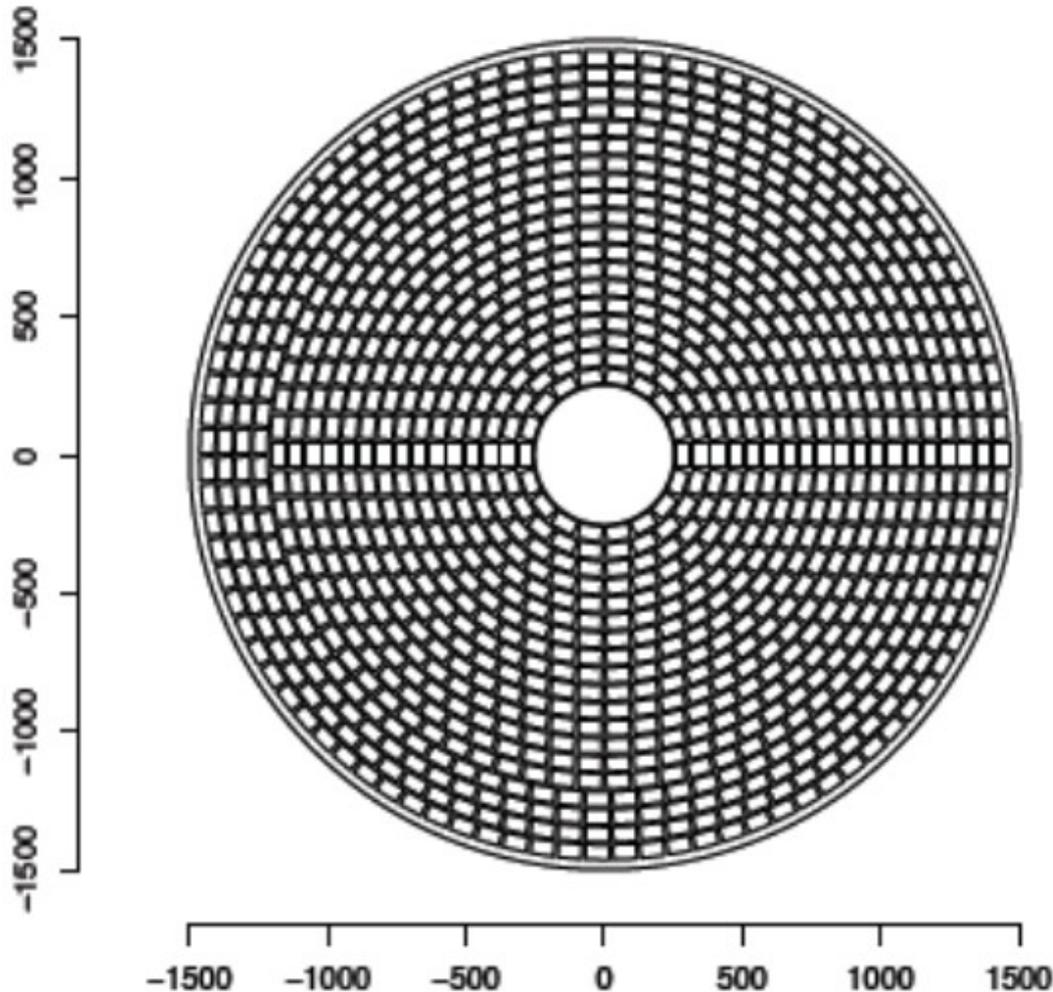
Grazing angle of incidence
0.2-1.2 deg

X-rays



- ▶ Typical X-ray astronomy optics
 - Often approximated by two conical frustra
 - Full shells

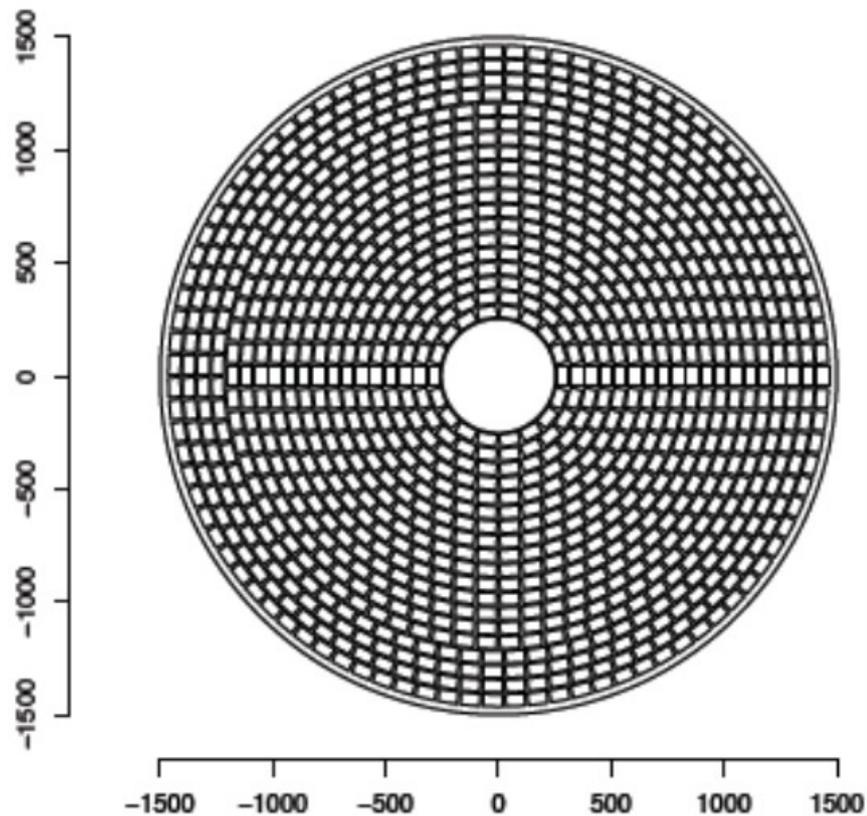
Possible next large mission



- ▶ More than 2m diameter
 - ▶ More than 10m focal length
 - Need to keep incidence angles small
- ▶ Segmented
 - Because single shell approach does not scale

What do we want to do?

- ▶ Characterize large aperture ($>2\text{m}$) long focal length ($>10\text{m}$) X-ray mirrors
 - Before they are finished
 - Modular construction: feedback data into on-going production
 - In spite of their size
 - Facilities cannot accommodate them when finished



What are the problems?

Why $F=20\text{m}$? Focal length of ATHENA proposal to the European Space Agency

- ▶ X-ray facilities are too small
 - Might accommodate $F=20\text{m}$ (PANTER and BESSY II can)
 - Cannot accommodate complete aperture

- ▶ Full-aperture illumination not possible
 - Beam would have significant divergence

- ▶ Need early feedback on mirror production
 - Cannot wait the 1-2 years required to complete the mirror
 - Want to be able to screen/select modules during production

- ▶ Would like to garner information to feed a model of the optics
 - Develop numerical model of the performance of the mirror
 - Use lab metrology to predict performance without complete X-ray characterization

What can one hope to have?

- ▶ Full illumination of sub-modules
 - @ PANTER (see presentations by Vadim Burwitz and Benedikt Menz)

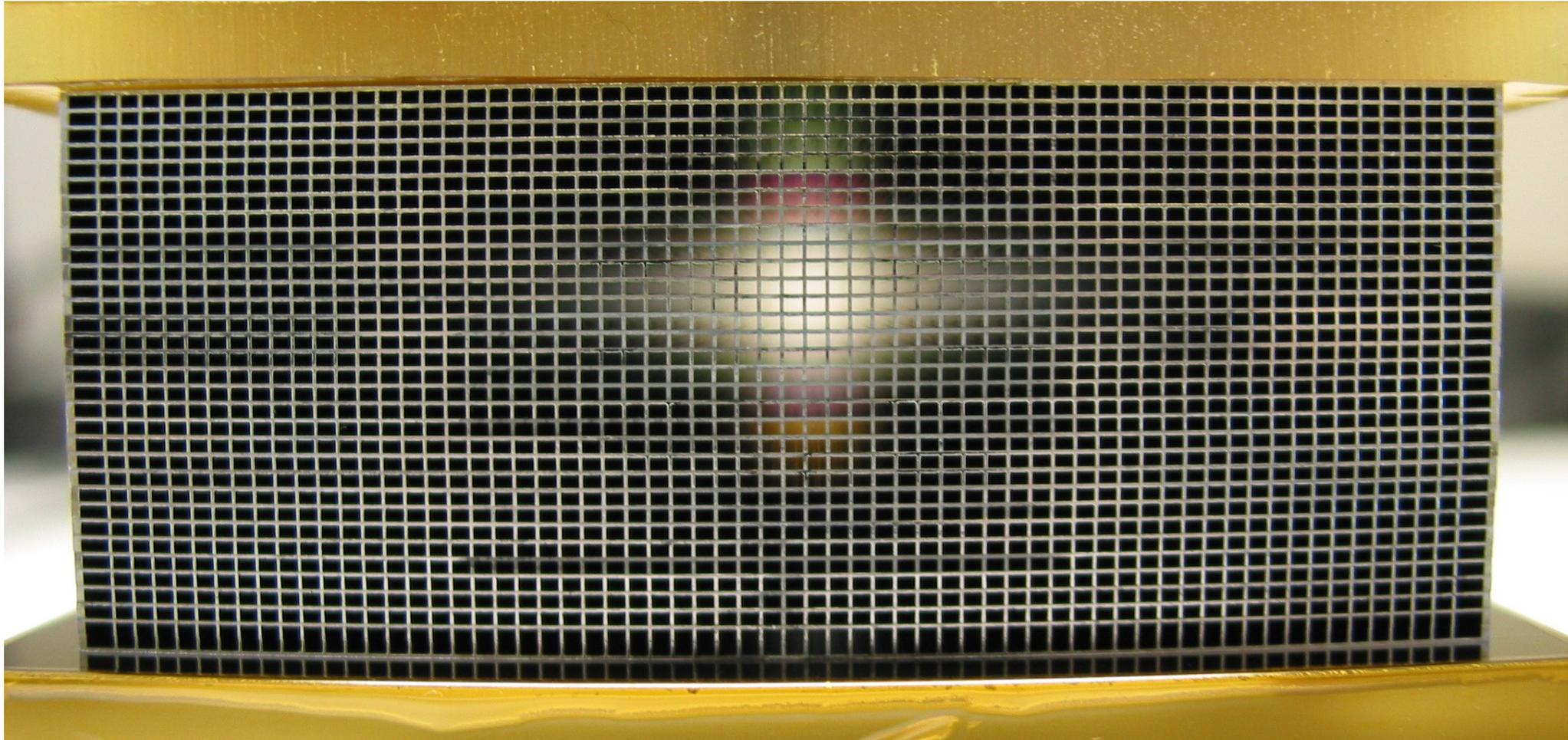
- ▶ Intra-focal pencil beam measurements
 - @ BESSY II XPBF, detector @ 5m

- ▶ For $F=20\text{m}$, in focus pencil beam measurements
 - @ BESSY II X-ray Pencil Beam Facility
 - Only 3-4 weeks/year

- ▶ We routinely use the BESSY II XPBF facility

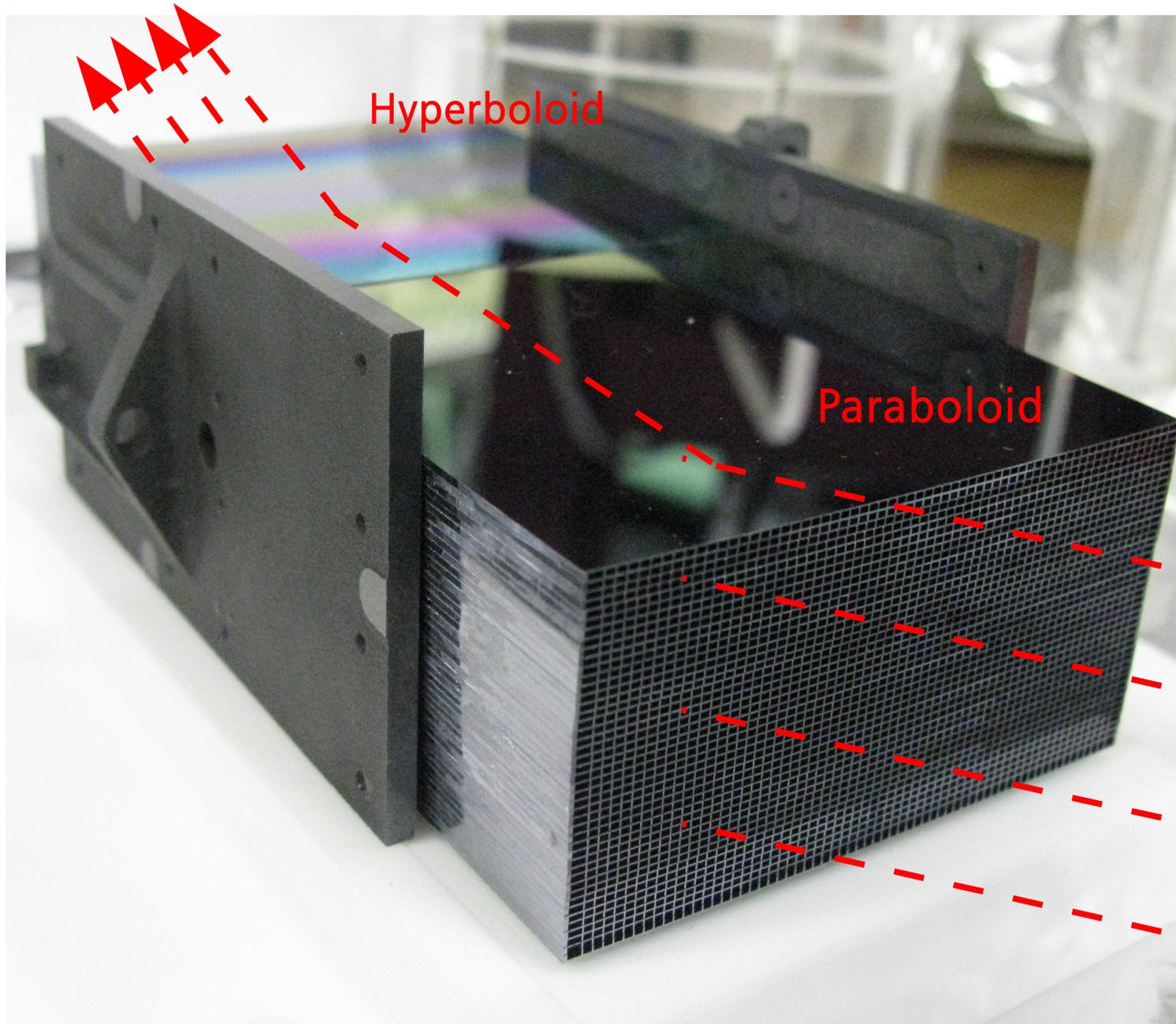
Silicon pore optics: reminder of what they look like

66mm

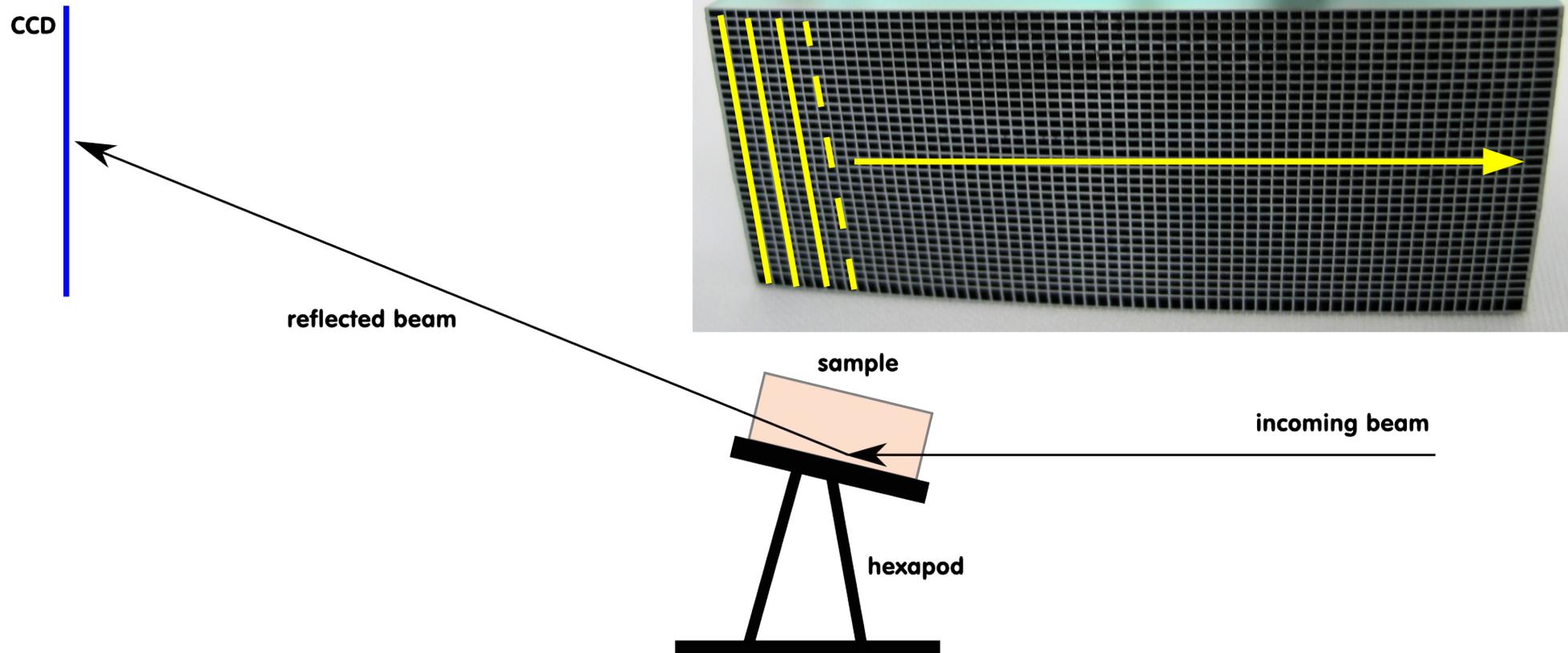


Silicon Pore Optics fabrication was explained yesterday by Marcelo Ackermann

Two SPO modules in a Wolter I configuration

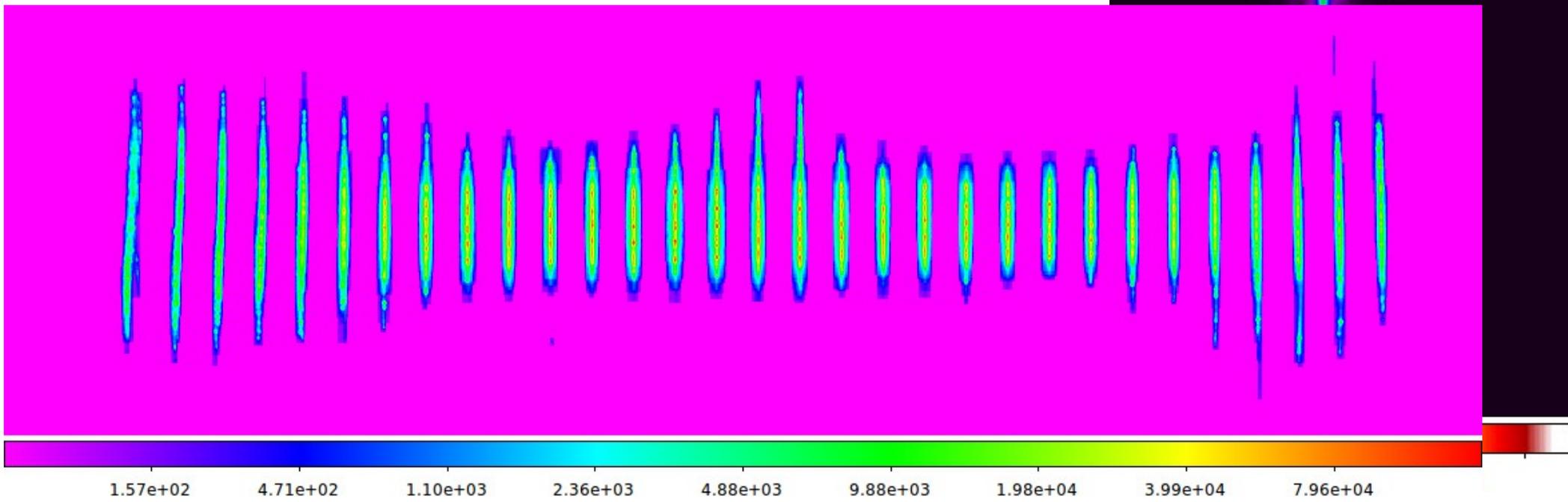
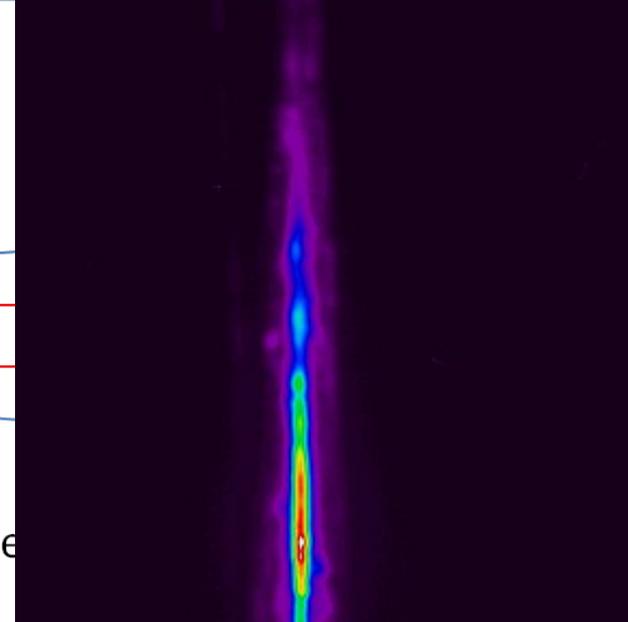
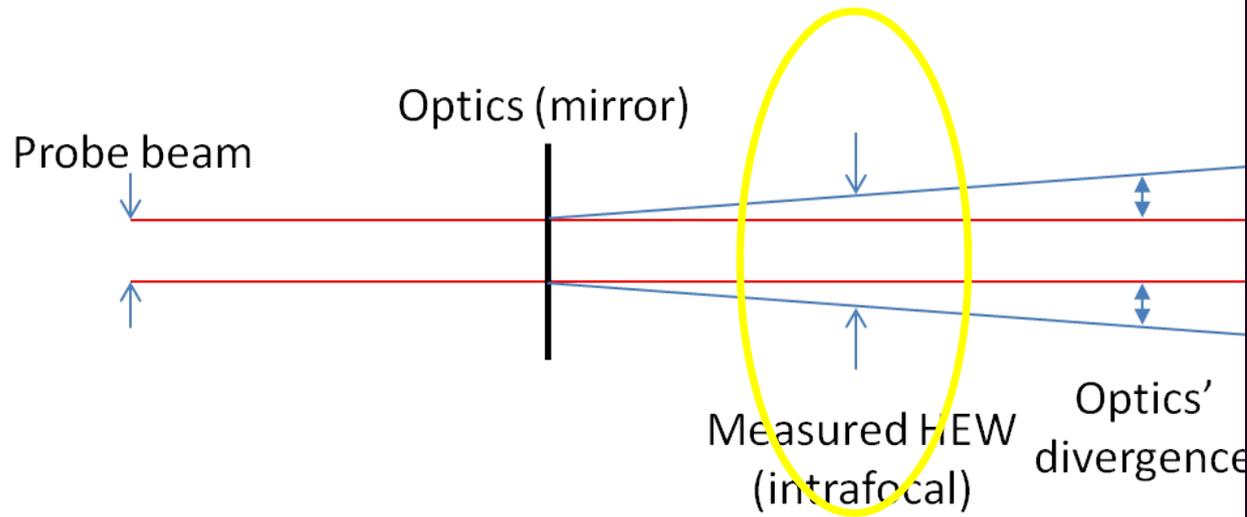


Pencil beam measurements



- ▶ Sample moved across the beam
 - Top hat, $100\ \mu\text{m}$ squared, divergence somewhat less than 1°
- ▶ CCD moved to intercept the beam
- ▶ Software re-assembles picture as if the beam had moved across the sample

Pencil beam measurements



Extract information from measurements

- ▶ Use the shape of the reflected beam to derive statistical information on the surface properties (see poster by Mark Vervest)
- ▶ Predicted vs measured position of the reflected spot to measure the large scale deformations
- ▶ Feed into numerical model of the optics to predict performance
- ▶ Predict 20m (in-focus) performance from 5m (intra-focal) data

Pencil beam measurements and predictions so far

- ▶ Samples measured at 5m or 20m in various stages of production
- ▶ Forward tracing method used extensively
- ▶ One SPO mirror module measured at BESSY II (5m, 20m) and PANTER (in focus)
 - HEW results are in agreement within a few seconds of arc
 - Forward tracing from intra-focal measurements seems to work.
- ▶ Validating the method and validating the algorithm at the same time
 - Less than ideal
 - Wish to validate the algorithm with reference optics that have extensive metrology

Concerted validation effort with reference optics

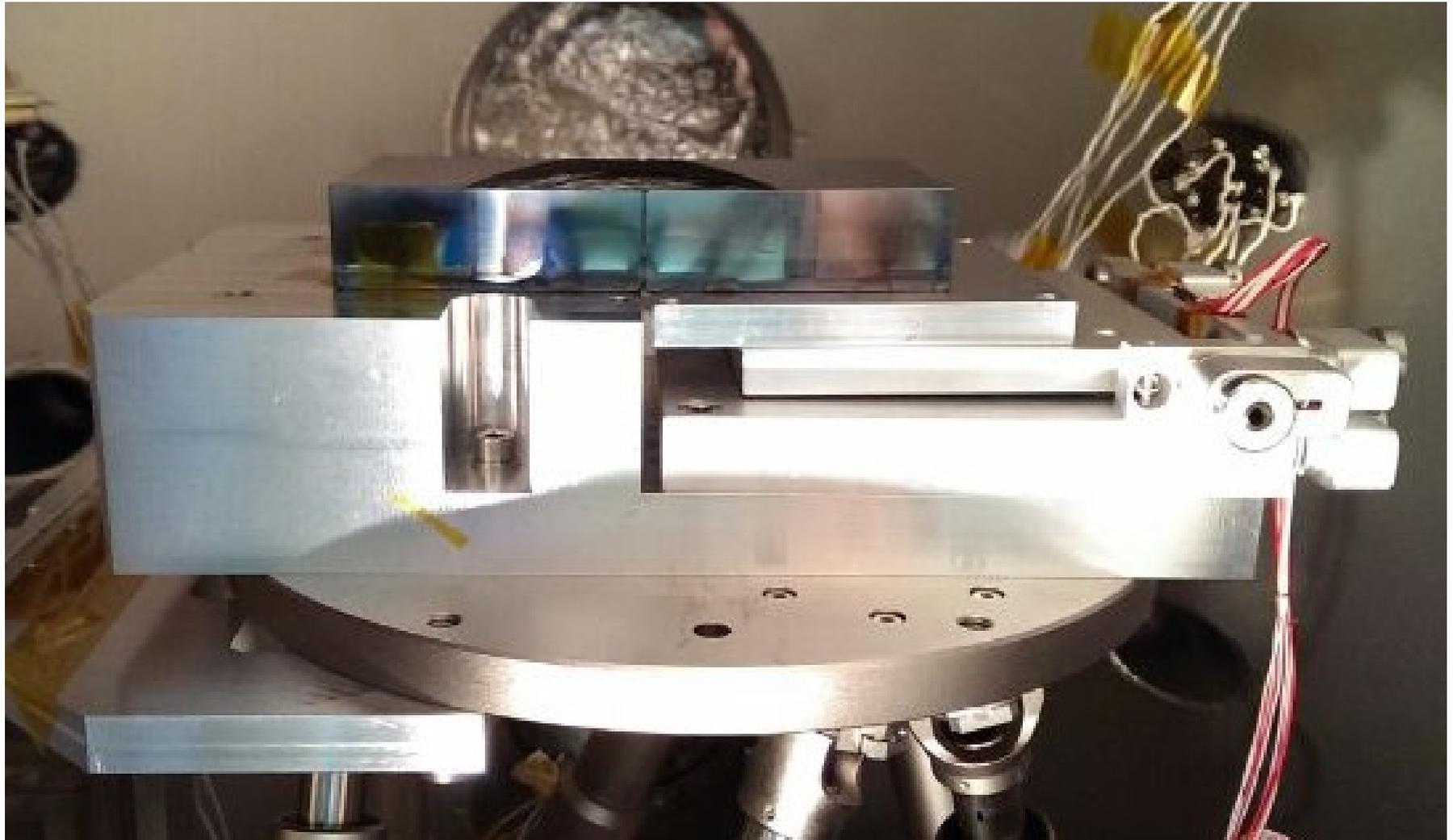
- ▶ Two mandrels that will eventually be used for SPO production
 - Conical: approximate paraboloid/hyperboloid
 - Surface better than 1" rms (Zeiss)
 - Measured also at NOM
 - Will be measured with our own metrology set up (fringe reflection technique)

- ▶ X-ray measurements at BESSY II (5m configuration, done)
 - Individually and as a Wolter I system
 - Does the method work on reference optics?
 - Predict in-focus performance of Wolter I system for later verification

- ▶ Same measurements at BESSY II in 20m configuration (to be done, week 47)
 - Do 5m predictions match in-focus measurements?

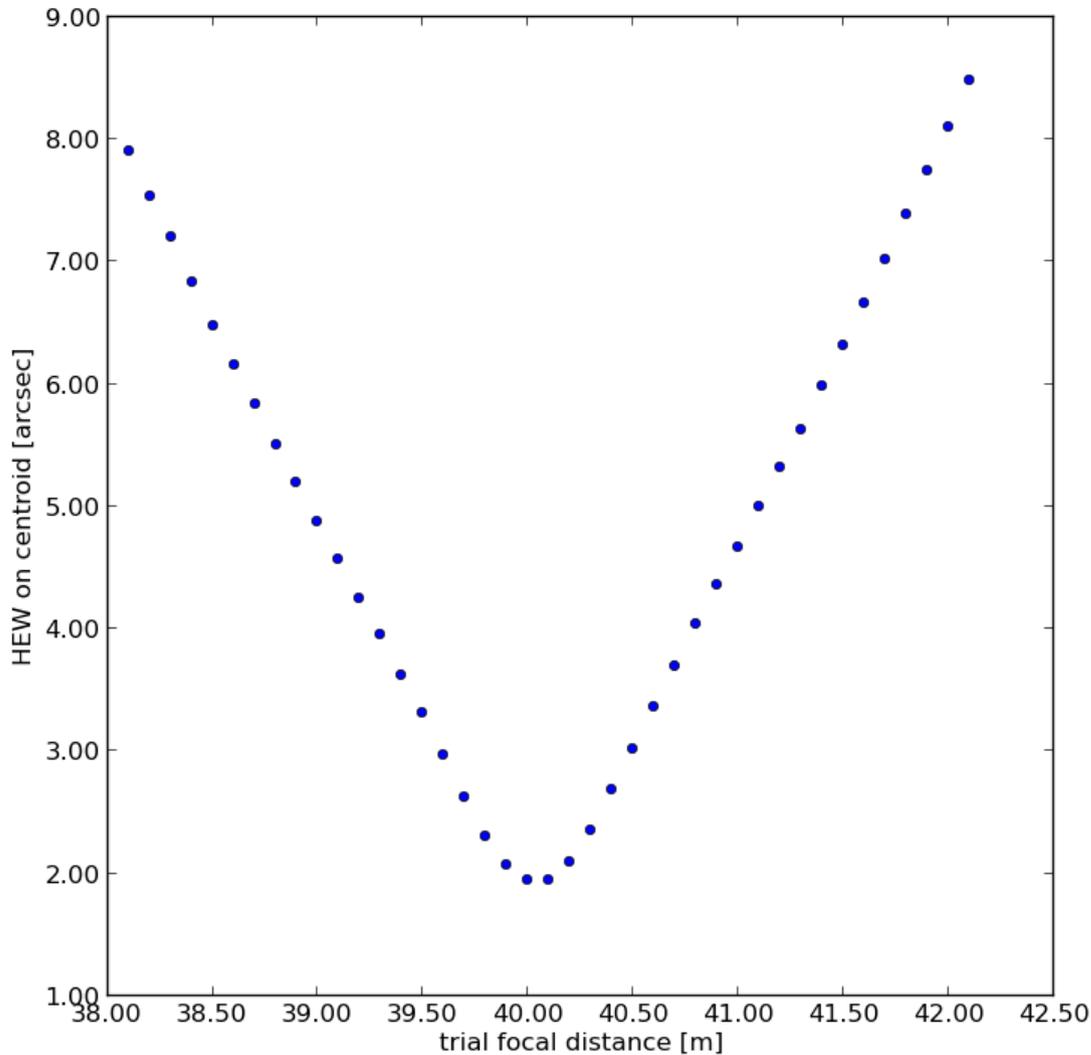
Reference optics: two mandrels

Radius of curvature 737mm
Dimensions 65x65 mm²



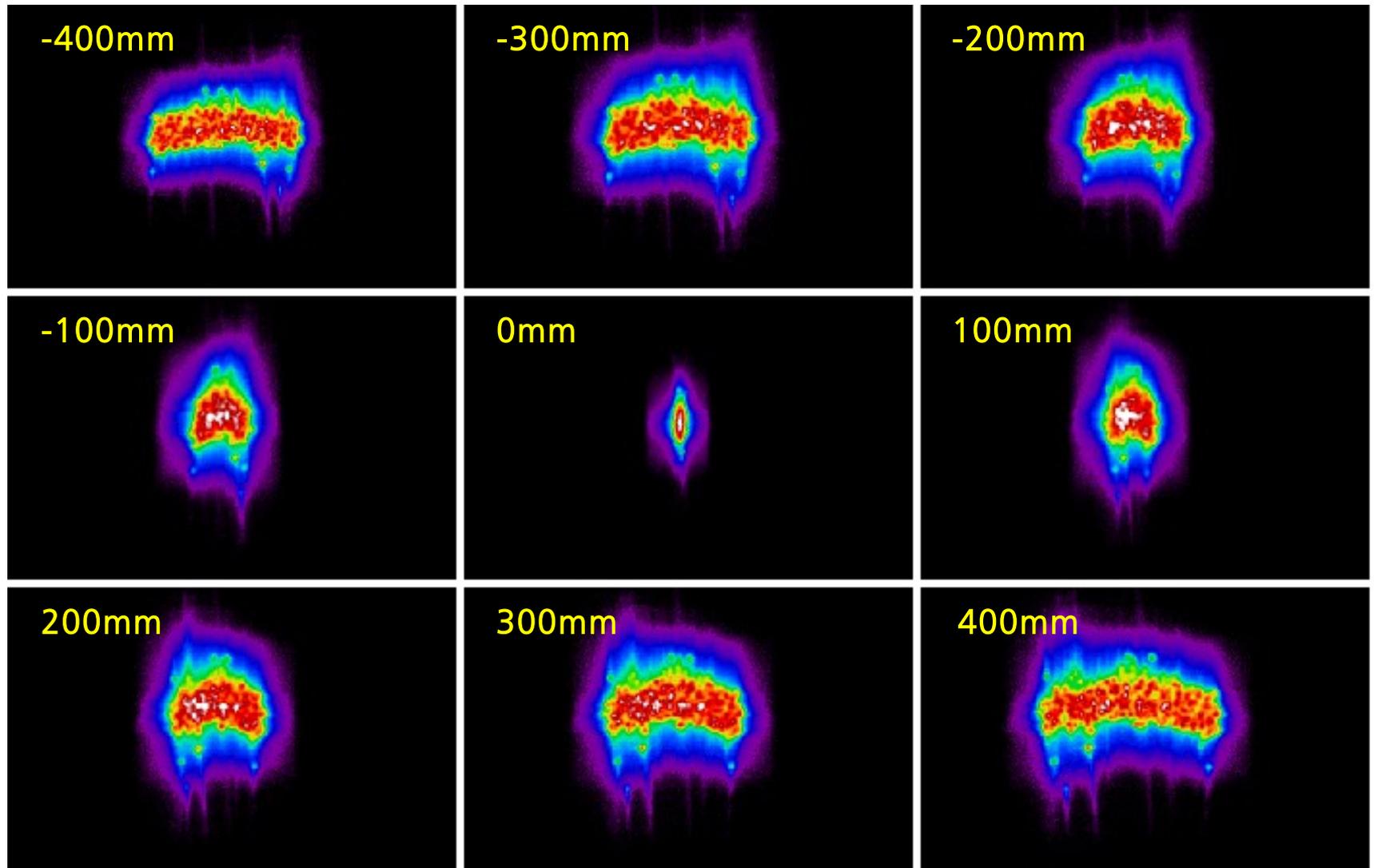
Parabolic mandrel focuses at $2xF=40\text{m}$ (preliminary result)

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- ▶ 5m data used to calculate where the optics focus
- ▶ Use Half Energy Width to determine the best focus
 - HEW = Half Power Diameter
- ▶ Exact focus expected at 40013mm
- ▶ The optics have a depth of focus of a few mm

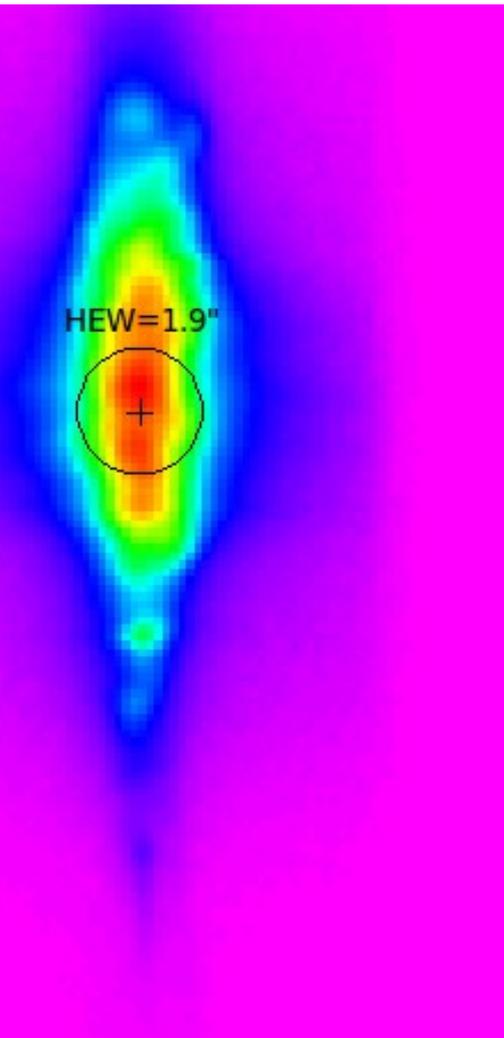
Conical mandrel: tracing around the expected focus



Based on 5m/intra-focal data

Predicted in-focus performance

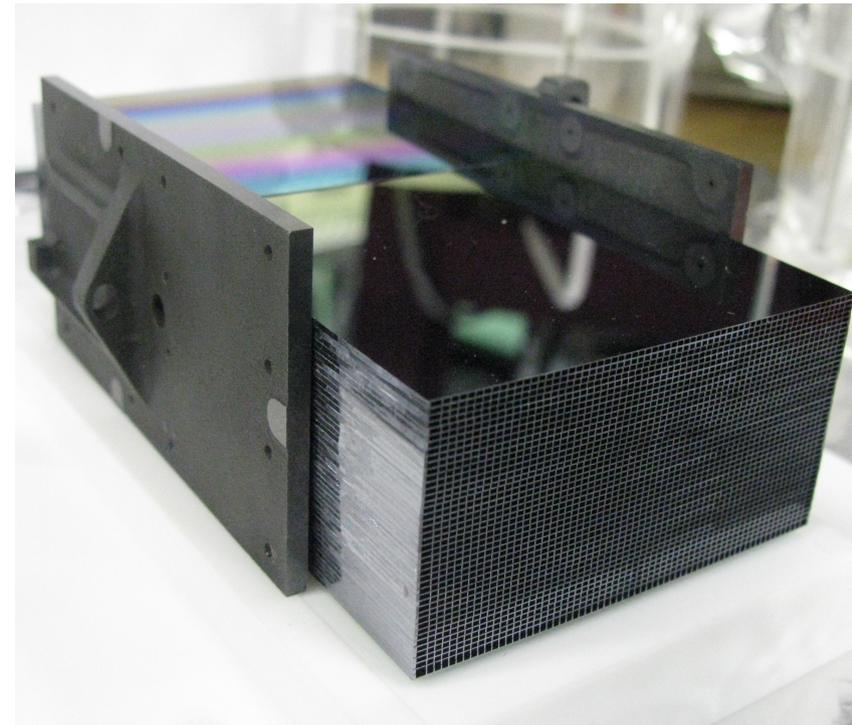
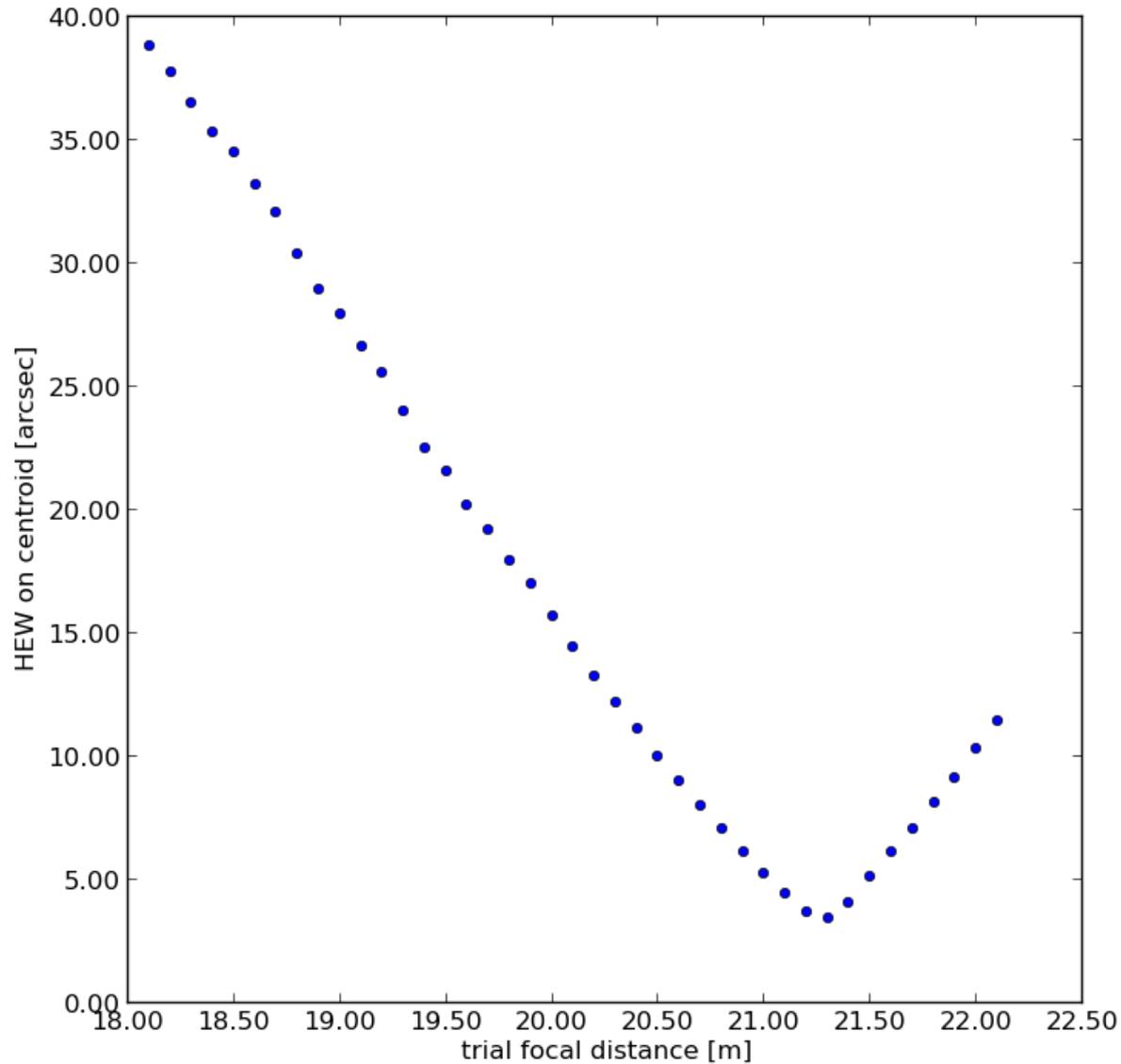
Parabolic mandrel: based on geometry and metrology expect HEW about 2"



- ▶ Forward tracing algorithm puts the focus at the expected distance and with the expected optical performance

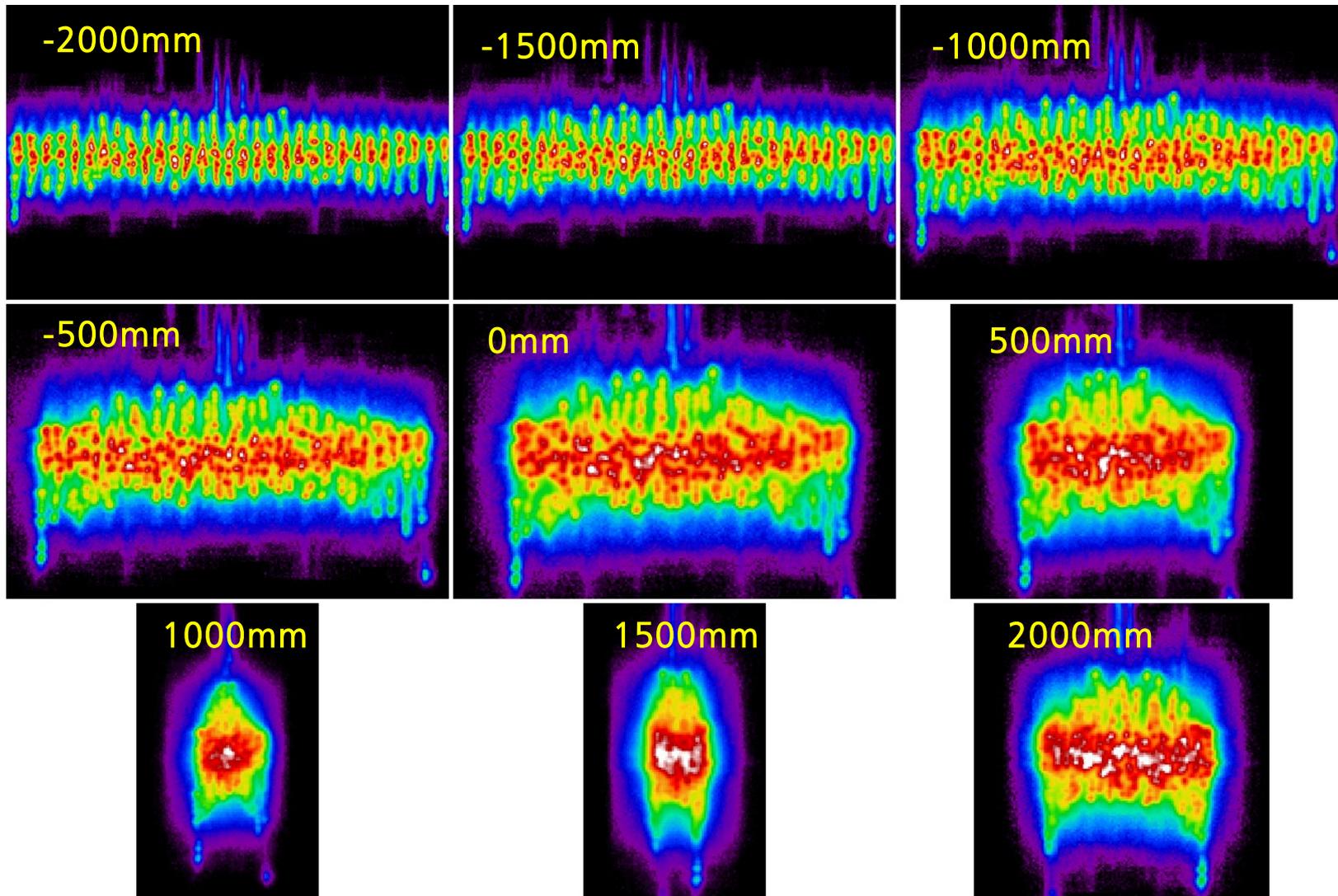
Wolter I combination (F=20m)

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Shallower kink angle puts focus at somewhere beyond 21m

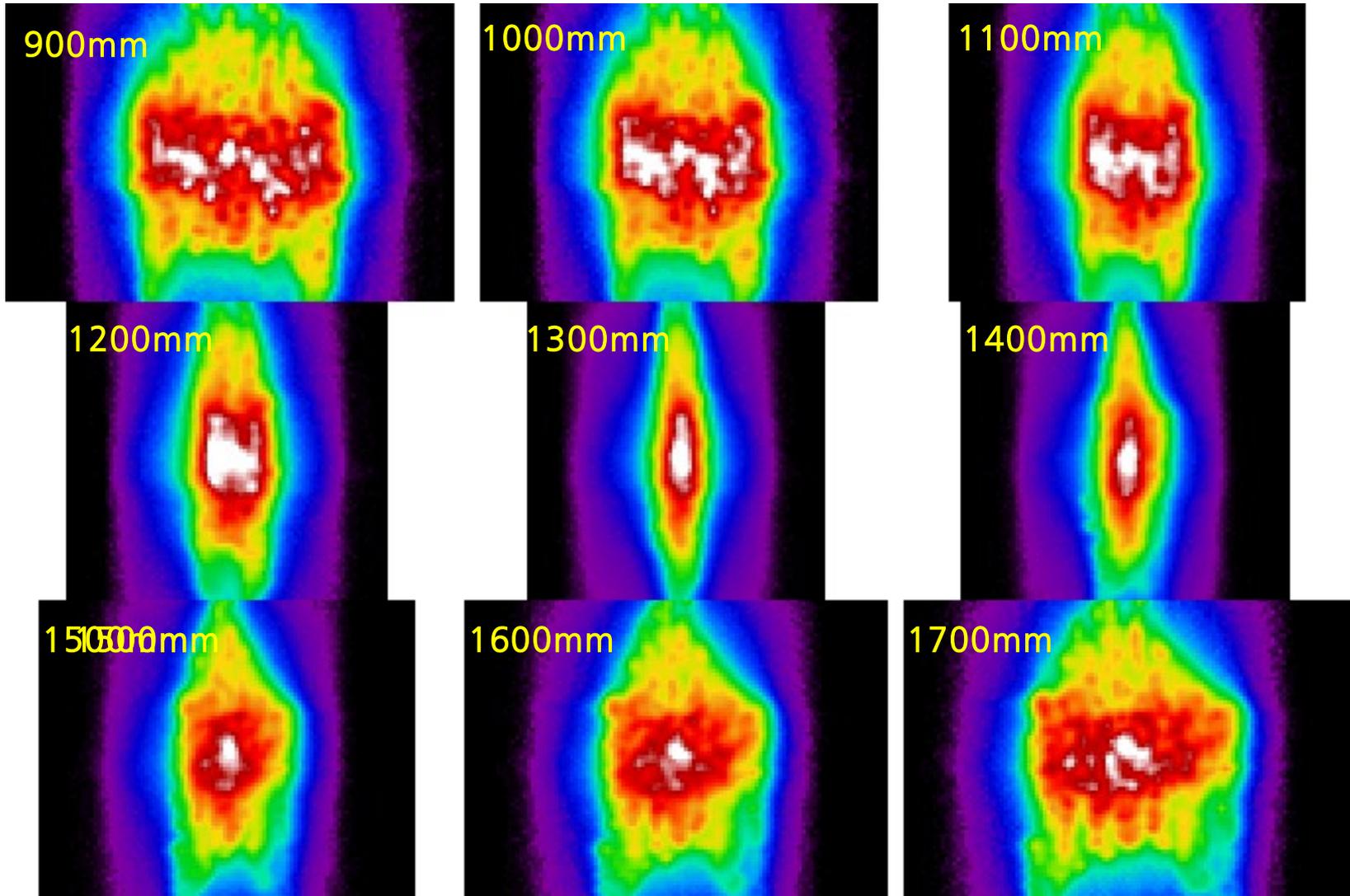
Wolter I combination: forward tracing



Based on 5m/intra-focal data

Wolter I combination: forward tracing

Best focus HEW around 4"



Based on 5m/intra-focal data

Final remarks

- ▶ Characterization of large X-ray optics with pencil beam a necessity
- ▶ Working on theoretical understanding of BESSY II pencil beam data
 - But method of wider applicability
- ▶ Tracing of 5m data to 20m and comparison with in-focus measurements in agreement on one SPO mirror module
 - But it was not a reference optics
- ▶ Tracing 5m/20m on reference optics
 - Mandrels + Wolter I combination @ 5m
 - Mandrels + Wolter I @ 20m (week 47 @ BESSY II)
- ▶ Aim to fully validate the method and the software in order to speed up the characterization of mirror modules without the need for in-focus measurements
- ▶ Aim to couple measurements to metrology and simulations to select/evaluate optics to limit the need for X-ray measurements

cosine |



measurement systems

cosine

J.H. Oortweg 19
2333 CH Leiden
The Netherlands

Tel. +31 71 528 49 62
Fax. +31 71 528 49 63
info@cosine.nl